COMPARISON OF DEGRADATION RATES OF INDIVIDUAL MODULES HELD AT MAXIMUM POWER

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ABSTRACT

In this paper, we present a comparison of maximum power degradation rates of individual modules under outdoor conditions in Golden, Colorado. Test modules include single- and polycrystalline-Si (x-Si, poly-Si), amorphous Si (a-Si, single, dual, and triple junction), CdTe, Cu-In-Ga-Se-S (CIS), and c-Si/a-Si heterostructure, from nine difference manufacturers. From monthly blocks of output power data, ratings were determined using multiple regressions to Performance Test Conditions (PTC). Plotting the power ratings versus time allowed degradation rates to be calculated from linear regressions. We also include a summary of module degradation rates obtained from the open literature over the past five years. Compared with the common rule-of-thumb value of 1% per year, many modules are seen to have significantly smaller degradation rates. A few modules, however, degrade significantly faster.

INTRODUCTION

Accurate calculations photovoltaic (PV) of the energy delivered during the lifetime of a PV system require knowledge of the rate at which the output power of the modules installed in the system degrade over time. Actual values for degradation rates ($R_0$) are difficult to obtain because of the time required to observe the performance changes in a module. As a result, PV performance models have little or no actual $R_0$ data available for use. An example would be the PVWATTS system sizing software, which has the ability to include a loss due to age, but defaults to no loss [1]. Ref. [1] recommends a nominal value of 1% per year for module performance loss, which is a common rule-of-thumb in the PV industry. Therefore, the objective of this paper is to quantify module degradation rates.

PUBLISHED DEGRADATION RATES

The first step toward this objective was a literature search to see what information about $R_0$ is currently available. A search of the PV literature going back five years yielded only nine references, which itself is an indication of how difficult $R_0$ values are to obtain. These results are presented in Table 1. All but refs. [7] and [10] report degradation in modules exposed while operating as part of systems. It should be noted that $R_0$ values derived from system operation data can include unrelated factors such as inverter operation, maximum power tracking, or interconnect degradation, and therefore may not be indicative of module degradation rates. Gauging degradation rates from systems has the advantage of providing better statistics if all the component modules can be measured individually, as was done in refs. [2] and [3].

Refs. [2] and [3] include comparisons of degradation rates with earlier work. The studies documented in refs. [2] and [6] of systems that had been dismantled at the end of their useful life. Of these, the high $R_0$ (-5% per year) observed in the Tunisian system was attributed to browning of encapsulation and increased shunting at grain boundaries [6]. Encapsulation browning, delamination, and hot spots were observed in the Arcata, CA, x-Si system [3]. Ref. [7] represents a formal study of a variety of individual modules exposed outdoors while held at the maximum power. Unfortunately these results represent just a single year of exposure so it is difficult or impossible to see long-term trends.

DEGRADATION RATE MEASUREMENTS

Since 1993, a measurement system called the Performance and Energy Ratings Testbed (PERT) located on the roof of the Outdoor Test Facility (OTF) at NREL in Golden, CO (see Fig. 1). The PERT consists of latitude-tilt open exposure racks; modules under test are connected to three Raydec Multi-Tracer II 15-channel electronic loads with individual four-wire electrical connections. Thermocouples measure back-of-module temperatures (the PERT has been described in detail previously [11]). The electronic loads perform maximum power point tracking, and also periodically measure the current-voltage (I-V) curves of the test modules (typically every 15 minutes).

Each individual I-V curve is stored as a separate file and archived. Next, the I-V data are post-processed by fitting each curve to a polynomial. The maximum power is calculated from the polynomial and then stored in a monthly summary file along with the total irradiance $E$.

1 This work has been authored by an employee or employees of the Midwest Research Institute under Contract No. DE-AC36-99GO10337 with the U.S. Department of Energy. The United States Government retains and the publisher, by accepting the article for publication, acknowledges that the United States Government retains a non-exclusive, paid-up, irrevocable, worldwide license to publish or reproduce the published form of this work, or allow others to do so, for United States Government purposes.
(measured with a global pyranometer in the same plane), the ambient temperature $T$, and the wind speed $s$.

**Fig. 1. The Performance and Energy Ratings Testbed.**

For each month of module maximum power data, a multiple linear regression to Eq. 1 is performed (the monthly power data are filtered by excluding points with irradiance values below 800 W/m$^2$).

$$P = E(a_1 + a_2E + a_3T + a_4s)$$  \hspace{1cm} (1)

In Eq. 1, $a_1$, $a_2$, $a_3$, and $a_4$ are the coefficients resulting from the regression analysis. Using the regression coefficients, the power produced by a test module at Performance Test Conditions (PTC), which are 1000 W/m$^2$ irradiance, 20$^\circ$C ambient temperature, and 1 m/s wind speed, is calculated by substitution back into Eq. 1. This power value is termed the PTC rating power [9]. Plotting the PTC ratings versus time reveals trends in the module performance. An example is shown in Fig. 1 for a BP Solar x-Si module, and Table 2 lists all the $R_0$ values obtained from PERT I-V data. Note that a number of the rows in Table 2 are for non-commercial prototype modules and therefore these $R_0$ values should not be construed to be representative of current products.

**DISCUSSION**

Although the PTC regression method has been shown to be a sensitive indicator of performance losses [8,9], it does not provide information about the nature of losses, such as decreasing fill factor due to series resistance increases. These have to be determined through analysis of changes in I-V parameters and examination of the modules. $R_0$ values as high as those observed in ref. [6] are likely indicative of abnormal problems with the module or system design.

It should be noted that degradation rates are related to failure rates, but not directly. Consider the so-called bathtub curve model of failure rates, which uses the Weibull cumulative distribution function $F(t)$ (see Fig. 1 and Eq. 2 in ref. [12]) to describe the mean time between failures. Because modules continue to operate while the output power is decreasing, slow degradation can’t be considered either infant mortality or useful life failures. Instead, it should be regarded as a factor contributing to wear-out. If all the modules in a system degrade at a similar rate, all will be considered unacceptable simultaneously (for example, if the array is no longer able to meet the input voltage window of the inverter), and thus the slope of wear-out period will be steep (i.e. the shape parameter $\beta$ for $F(t)$ will be large, $\gg 1$).
It is interesting to note that many of the \( R_0 \) values for crystalline Si modules in Tables 1 and 2 are significantly lower than the 1 \% per year rule-of-thumb. This is also true for some thin-film modules, although most are slightly above this level. These are an indication of the excellent quality of PV modules, even when in continuous operation outdoors for many years. A few degradation rates are significantly higher, with obvious implications for system performance over time. Thus, \( R_0 \) information should be available for the system designer.

The values reported in Table 2 represent the climate conditions in Golden, CO. Although they are comparable in magnitude with previously published values, it is possible that \( R_0 \) could vary in other climates for the same module type. This might be an interesting research topic.

CONCLUSIONS

A number of conclusions can be made from these results. First, module degradation rate determinations should be made from performance data over periods of at least three years. Shorter time spans are likely to give inaccurate \( R_0 \) values because of seasonal variations and initial module performance stabilization.

Second, many (but not all) crystalline Si modules degrade at rates slower than the 1 \% per year rule-of-thumb. A more reasonable rule-of-thumb is probably 0.5 \% per year. Conversely, many (but not all) thin-film modules appear to have \( R_0 \) values somewhat higher than 1 \% per year.

Third, \( R_0 \) appears to vary over a fairly wide range, from values as high as several percent per year, down to zero (no measurable degradation). It would therefore seem important for system designers to have accurate degradation rate information available.

ACKNOWLEDGEMENT

This work is supported or funded under DOE Contract No. DE-AC36-99GO10337.

REFERENCES


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Table 1. PV module degradation rates published within the past five years.

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Table 2. PV module degradation rates obtained from monthly PTC regressions of PERT I-V data. Module types marked with a † indicate non-production prototypes that are not indicative of current products.